

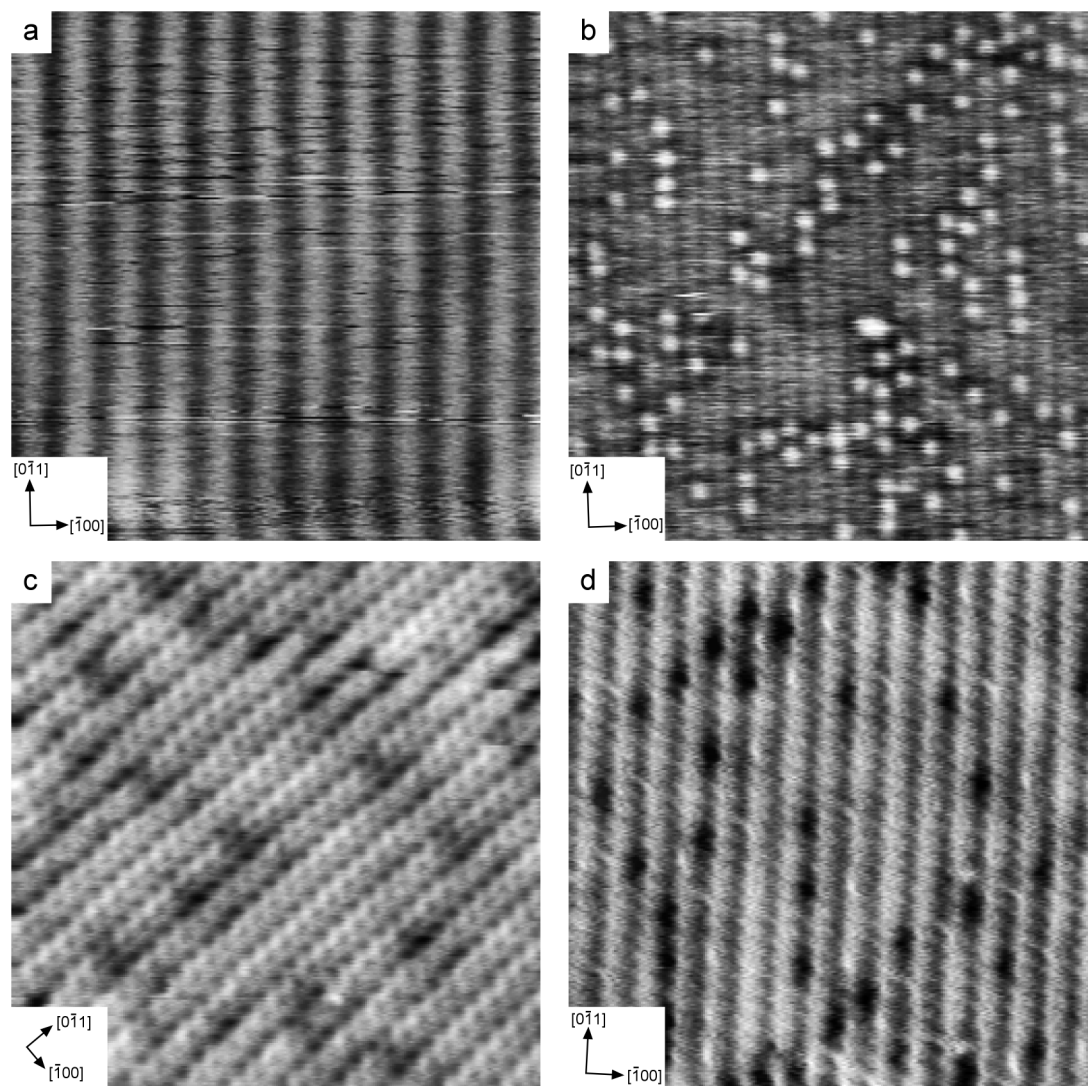
Supporting Information for:

Imaging the  $\text{TiO}_2(011)-(2\times 1)$  Surface using  
Noncontact Atomic Force Microscopy and  
Scanning Tunneling Microscopy

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**Figure S1** NC-AFM images of the  $\text{TiO}_2(011)-(2\times 1)$  surface with different contrasts. Image parameters are: **(a)**  $(100 \text{ \AA})^2$ ,  $\Delta f = -11.9 \text{ Hz}$ ,  $V_{\text{CPD}} = 1.8 \text{ V}$ ; **(b)**  $(200 \text{ \AA})^2$ ,  $\Delta f = -60.5 \text{ Hz}$ ,  $V_{\text{CPD}} = 1.5 \text{ V}$ ; **(c)**  $(125 \text{ \AA})^2$ ,  $\Delta f = -14.4 \text{ Hz}$ ,  $V_{\text{CPD}} = 1.8 \text{ V}$ ; and **(d)**  $(137.5 \text{ \AA})^2$ ,  $\Delta f = -13.1 \text{ Hz}$ ,  $V_{\text{CPD}} = 1.8 \text{ V}$ .